BT1308W series D

Triacs logic level
Rev. 01 — 27 February 2008

Product data sheet

Product profile

1.1 General description

Passivated sensitive gate triacs in a SOT223 surface-mountable plastic package

1.2 Features

- Sensitive gate
- Direct interfacing to logic level ICs
- Gate triggering in four quadrants
- Direct interfacing to low-power gate drive circuits

1.3 Applications

- General purpose switching and phase control
- Low-power AC fan speed controllers

1.4 Quick reference data

- $V_{DRM} \le 400 \text{ V (BT1308W-400D)}$
- $V_{DRM} \le 600 \text{ V (BT1308W-600D)}$
- $I_{TSM} \le 9 \text{ A (t = 20 ms)}$

- $I_{GT} \le 5 \text{ mA}$
- $I_{GT} \le 7 \text{ mA } (T2-G+)$
- $I_{T(RMS)} \le 0.8 A$

Pinning information

Table 1. **Pinning**

Pin	Description	Simplified outline	Graphic symbol
1	main terminal 1 (T1)		N 1
2	main terminal 2 (T2)	4	T2 T1
3	gate (G)		`G sym051
4	mounting base; main terminal 2 (T2)		
		SOT223	



3. Ordering information

Table 2. Ordering information

Type number	Package			
	Name	Description	Version	
BT1308W-400D	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223	
BT1308W-600D				

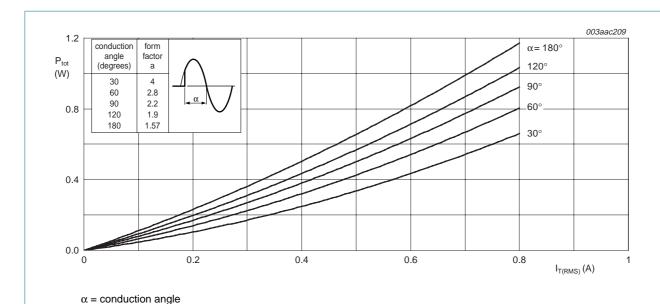
4. Limiting values

Table 3. Limiting values

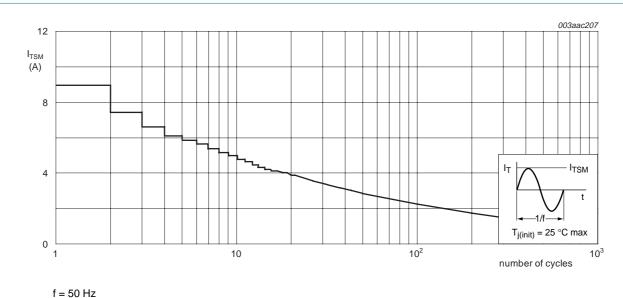
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage	BT1308W-400D	-	400	V
		BT1308W-600D	-	600	V
I _{T(RMS)}	RMS on-state current	full sine wave; $T_{sp} \le 107.4$ °C; see Figure 4 and 5	-	8.0	А
I _{TSM}	non-repetitive peak on-state current	full sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3			
		t = 20 ms	-	9	Α
		t = 16.7 ms	-	10	Α
l ² t	I ² t for fusing	$t_p = 10 \text{ ms}$	-	0.32	A ² s
dI _T /dt	rate of rise of on-state current	I_{TM} = 1 A; I_G = 20 mA; dI_G/dt = 0.2 A/ μs			
		T2+ G+	-	50	A/μs
		T2+ G-	-	50	A/μs
		T2- G-	-	50	A/μs
		T2- G+	-	10	A/μs
I_{GM}	peak gate current		-	1	Α
P_GM	peak gate power		-	5	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.1	W
T_{stg}	storage temperature		-40	+150	°C
T _j	junction temperature		-	125	°C

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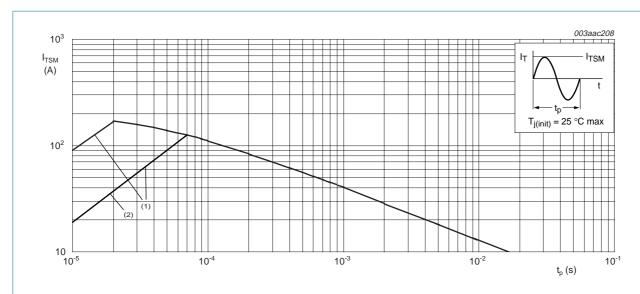


Total power dissipation as a function of RMS on-state current; maximum values Fig 1.



Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum Fig 2. values

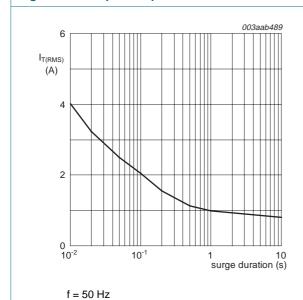
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 $t_p \le 20 \text{ ms}$

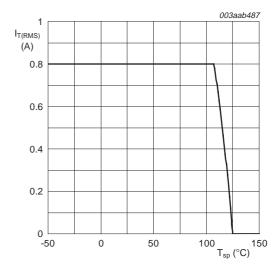
- (1) dI_T/dt limit
- (2) T2- G+ quadrant limit

Non-repetitive peak on-state current as a function of pulse width; maximum values Fig 3.



 $T_{sp} = 107.4 \, ^{\circ}C$

RMS on-state current as a function of surge Fig 4. duration; maximum values



RMS on-state current as a function of solder Fig 5. point temperature; maximum values

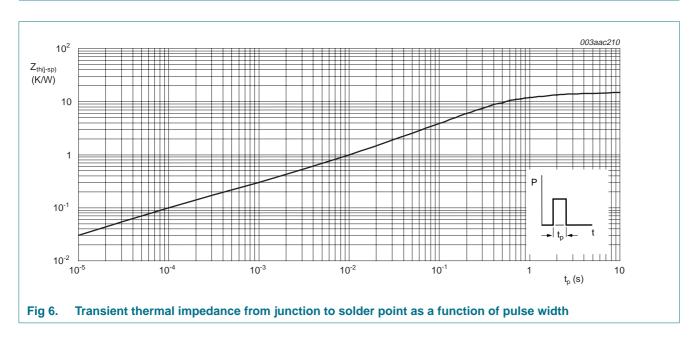
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Thermal characteristics

Table 4. **Thermal characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	full cycle; see Figure 6	-	-	15	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	full cycle				
		for minimum footprint; see Figure 13	-	156	-	K/W
		for pad area; see Figure 14	-	70	-	K/W



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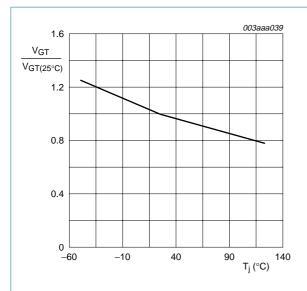
6. Characteristics

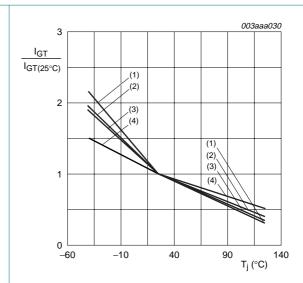
Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
I _{GT}	gate trigger current	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; see } \frac{\text{Figure 8}}{}$				
		T2+ G+	-	1	5	mΑ
		T2+ G-	-	2	5	mΑ
		T2- G-	-	2	5	mΑ
		T2- G+	-	4	7	mΑ
IL	latching current	$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; see } \frac{\text{Figure 10}}{\text{Figure 10}}$				
		T2+ G+	-	1	10	mΑ
		T2+ G-	-	5	10	mΑ
		T2- G-	-	1	10	mΑ
		T2- G+	-	2	10	mΑ
I _H	holding current	$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; see } \frac{\text{Figure 11}}{}$	-	1	10	mΑ
V _T	on-state voltage	I _T = 0.85 A; see <u>Figure 9</u>	-	1.35	1.6	V
V_{GT}	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 7}}{}$	-	0.9	2	V
		$V_D = V_{DRM}; I_T = 0.1 A; T_j = 110 ^{\circ}C$	0.1	0.7	-	V
I _D	off-state current	$V_D = V_{DRM(max)}$; $T_j = 125 ^{\circ}C$	-	0.1	0.5	mΑ
Dynamic	characteristics					
dV _D /dt	rate of rise of off-state voltage	$V_{DM} = 0.67 \times V_{DRM(max)}; T_j = 110 ^{\circ}C;$ exponential waveform; gate open circuit	30	45	-	V/μs
dV _{com} /dt	rate of change of commutating voltage	$V_{DM} = V_{DRM(max)}; T_j = 50 ^{\circ}C;$ $I_{TM} = 0.84 A; dI_{com}/dt = 0.3 A/ms$	-	5	-	V/μs
t _{gt}	gate-controlled turn-on time	$I_{TM} = 1 \text{ A}; V_D = V_{DRM(max)}; I_G = 25 \text{ mA}; dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs

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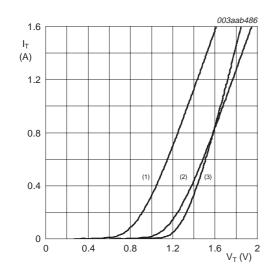




- (1) T2+ G+
- (2) T2-G+
- (3) T2-G-
- (4) T2+ G-

Fig 7. Normalized gate trigger voltage as a function of junction temperature





 $V_0 = 1.171 \text{ V}$

 $R_s = 0.5125 \Omega$

- (1) $T_i = 125$ °C; typical values
- (2) $T_i = 125 \,^{\circ}C$; maximum values
- (3) $T_j = 25 \,^{\circ}C$; maximum values

Fig 9. On-state current as a function of on-state voltage

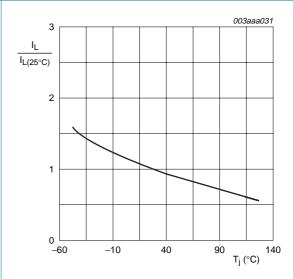
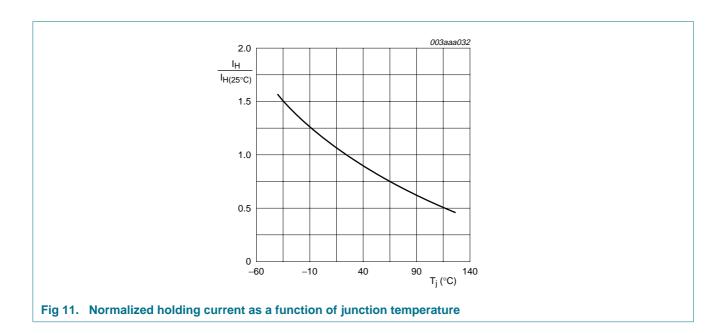


Fig 10. Normalized latching current as a function of junction temperature



Package outline

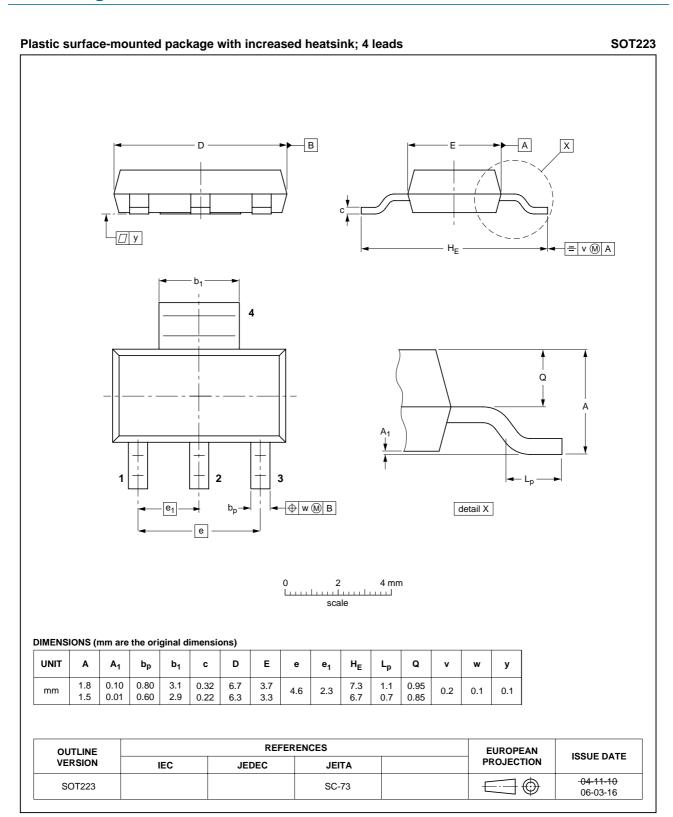


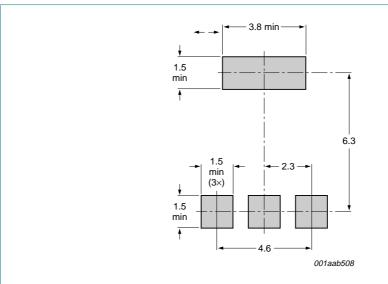
Fig 12. Package outline SOT223 (SC-73)

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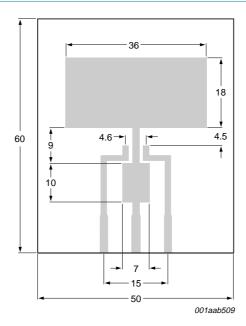
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8. Mounting



All dimensions are in mm.

Fig 13. Minimum footprint SOT223



All dimensions are in mm.

Printed circuit board: FR4 epoxy glass (1.6 mm thick), copper laminate (35 μ m thick).

Fig 14. Printed circuit board pad area SOT223

9. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BT1308W_SER_D_1	20080227	Product data sheet	-	-

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Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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